

Complementary MOSFET

ELM17600GA-S

■General Description

ELM17600GA-S uses advanced trench technology to provide excellent $R_{ds(on)}$ and low gate charge. Internal ESD protection is included.

■Features

- | | |
|--|--|
| N-channel
• $V_{ds}=20V$
• $I_d=0.9A(V_{gs}=4.5V)$
• $R_{ds(on)} < 300m\Omega(V_{gs}=4.5V)$
• $R_{ds(on)} < 350m\Omega(V_{gs}=2.5V)$
• $R_{ds(on)} < 450m\Omega(V_{gs}=1.8V)$ | P-channel
• $V_{ds}=-20V$
• $I_d=-0.6A(V_{gs}=-4.5V)$
• $R_{ds(on)} < 550m\Omega(V_{gs}=-4.5V)$
• $R_{ds(on)} < 700m\Omega(V_{gs}=-2.5V)$
• $R_{ds(on)} < 950m\Omega(V_{gs}=-1.8V)$ |
|--|--|

■Maximum Absolute Ratings

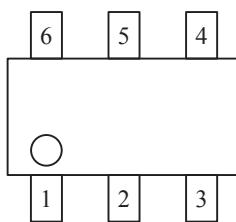
Parameter	Symbol	N-ch (Max.)	P-ch (Max.)	Unit	Note
Drain-source voltage	V_{ds}	20	-20	V	
Gate-source voltage	V_{gs}	± 8	± 8	V	
Continuous drain current	I_d	0.90	-0.60	A	1
Ta=70°C		0.70	-0.48		
Pulsed drain current	I_{dm}	5	-3	A	2
Power dissipation	P_d	0.30	0.30	W	
Ta=70°C		0.19	0.19		
Junction and storage temperature range	T_j, T_{stg}	-55 to 150	-55 to 150	°C	

■Thermal Characteristics

Parameter	Symbol	Device	Typ.	Max.	Unit	Note
Maximum junction-to-ambient	$R_{\theta ja}$	N-ch	360	415	°C/W	1
Maximum junction-to-ambient			400	460	°C/W	
Maximum junction-to-lead			300	350	°C/W	3
Maximum junction-to-ambient	$R_{\theta ja}$	P-ch	360	415	°C/W	1
Maximum junction-to-ambient			400	460	°C/W	
Maximum junction-to-lead			300	350	°C/W	3

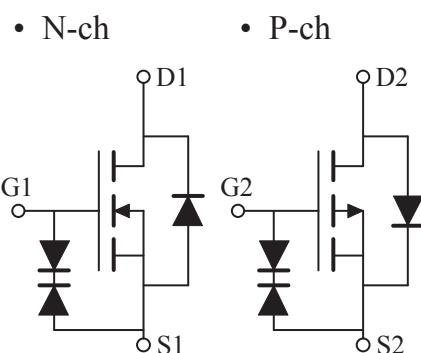
■Pin configuration

SC-70-6(TOP VIEW)



Pin No.	Pin name
1	SOURCE1
2	GATE1
3	DRAIN2
4	SOURCE2
5	GATE2
6	DRAIN1

■Circuit



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■Electrical Characteristics (N-ch)

T_a=25°C

Parameter	Symbol	Conditions		Min.	Typ.	Max.	Unit	
STATIC PARAMETERS								
Drain-source breakdown voltage	BV _{dss}	Id=250μA, V _{gs} =0V		20			V	
Zero gate voltage drain current	Id _{ss}	V _{ds} =16V, V _{gs} =0V	T _j =55°C			1	μA	
						5		
Gate-body leakage current	I _{gss}	V _{ds} =0V, V _{gs} =±8V				25	μA	
Gate threshold voltage	V _{gs(th)}	V _{ds} =V _{gs} , Id=250μA		0.50	0.75	0.90	V	
On state drain current	Id(on)	V _{gs} =4.5V, V _{ds} =5V		5			A	
Static drain-source on-resistance	R _{ds(on)}	V _{gs} =4.5V, Id=0.9A	T _j =125°C		181	300	mΩ	
					253	330		
		V _{gs} =2.5V, Id=0.75A			237	350		
		V _{gs} =1.8V, Id=0.7A			317	450		
Forward transconductance	G _{fs}	V _{ds} =5V, Id=0.8A			2.6		S	
Diode forward voltage	V _{sd}	Is=0.5A, V _{gs} =0V			0.69	1.00	V	
Max.body-diode continuous current	Is					0.4	A	
DYNAMIC PARAMETERS								
Input capacitance	C _{iss}	V _{gs} =0V, V _{ds} =10V, f=1MHz			101	120	pF	
Output capacitance	C _{oss}				17		pF	
Reverse transfer capacitance	C _{rss}				14		pF	
Gate resistance	R _g	V _{gs} =0V, V _{ds} =0V, f=1MHz			3	4	Ω	
SWITCHING PARAMETERS								
Total gate charge	Q _g	V _{gs} =4.5V, V _{ds} =10V, Id=0.8A			1.57	1.90	nC	
Gate-source charge	Q _{gs}				0.13		nC	
Gate-drain charge	Q _{gd}				0.36		nC	
Turn-on delay time	t _{d(on)}	V _{gs} =5V, V _{ds} =10V, R _l =12.5Ω	R _{gen} =6Ω		3.2		ns	
Turn-on rise time	t _r				4.0		ns	
Turn-off delay time	t _{d(off)}				15.5		ns	
Turn-off fall time	t _f				2.4		ns	
Body-diode reverse recovery time	t _{rr}	I _f =0.8A, dI/dt=100A/μs			6.7	8.1	ns	
Body-diode reverse recovery charge	Q _{rr}	I _f =0.8A, dI/dt=100A/μs			1.6		nC	

NOTE :

1. The value of R_{θja} is measured with the device mounted on 1in² FR-4 board of 2oz. Copper, in still air environment with T_a=25°C. The value in any given applications depends on the user's specific board design, The current rating is based on the t ≤ 10s thermal resistance rating.
2. Repetitive rating, pulse width limited by junction temperature.
3. The R_{θja} is the sum of the thermal impedance from junction to lead R_{θjl} and lead to ambient.
4. The static characteristics in Figures 1 to 6 are obtained using 80μs pulses, duty cycle 0.5%max.
5. These tests are performed with the device mounted on 1in² FR-4 board with 2oz. Copper, in a still air environment with T_a=25°C. The SOA curve provides a single pulse rating.



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■ Typical Electrical and Thermal Characteristics (N-ch)

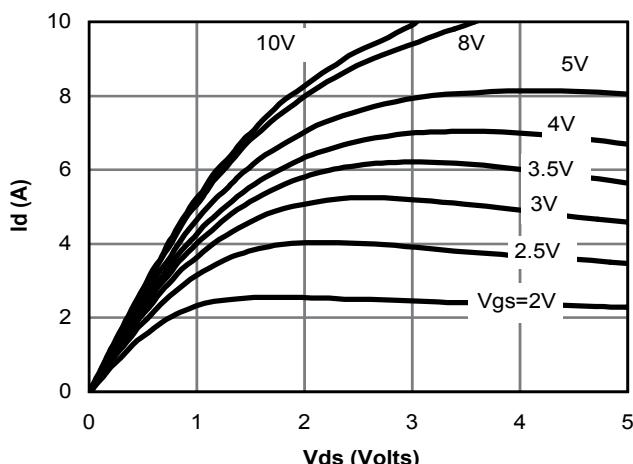


Fig 1: On-Region Characteristics

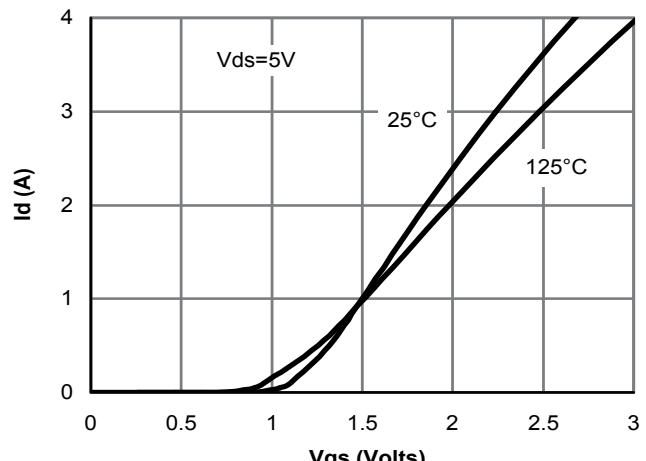


Figure 2: Transfer Characteristics

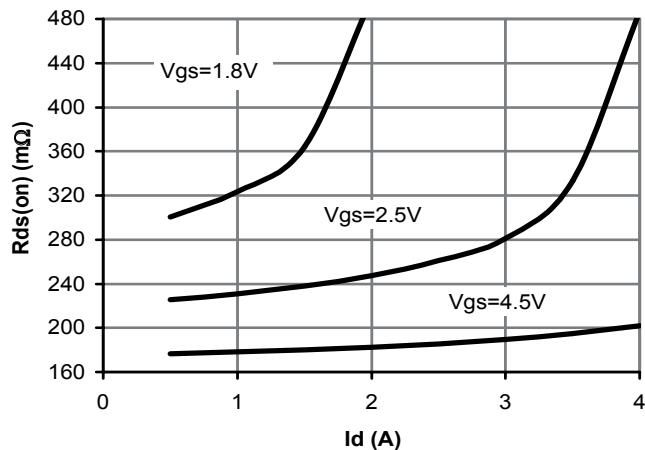


Figure 3: On-Resistance vs. Drain Current and Gate Voltage

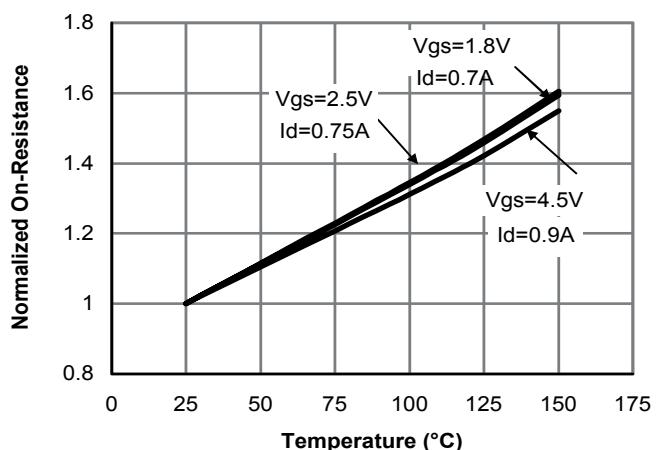


Figure 4: On-Resistance vs. Junction Temperature

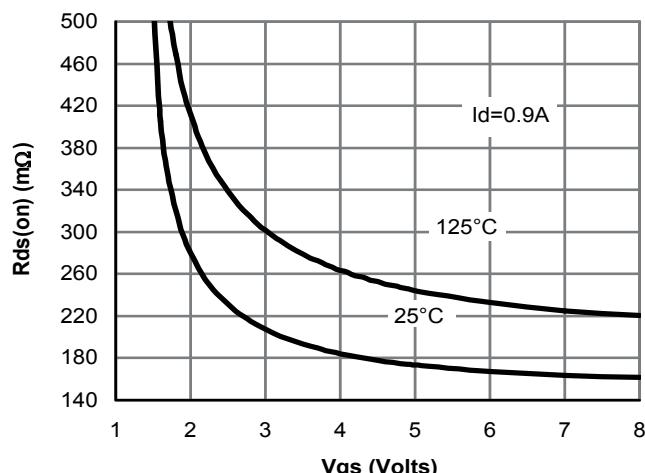


Figure 5: On-Resistance vs. Gate-Source Voltage

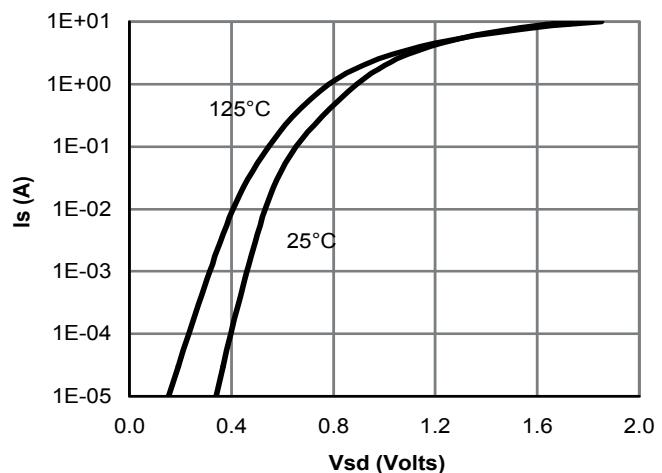
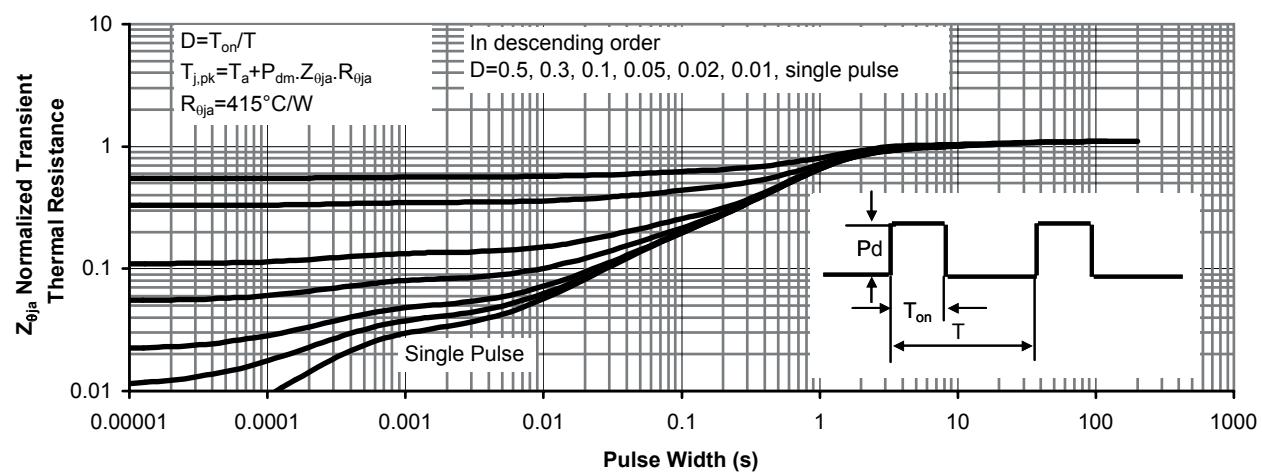
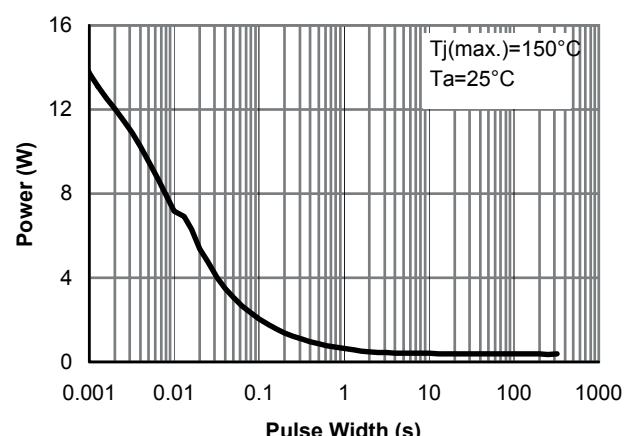
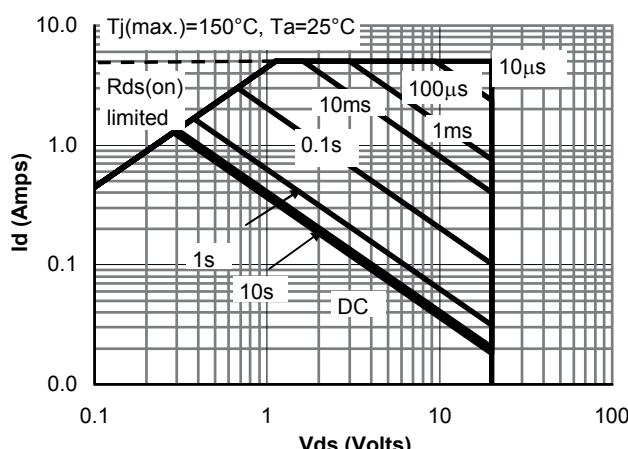
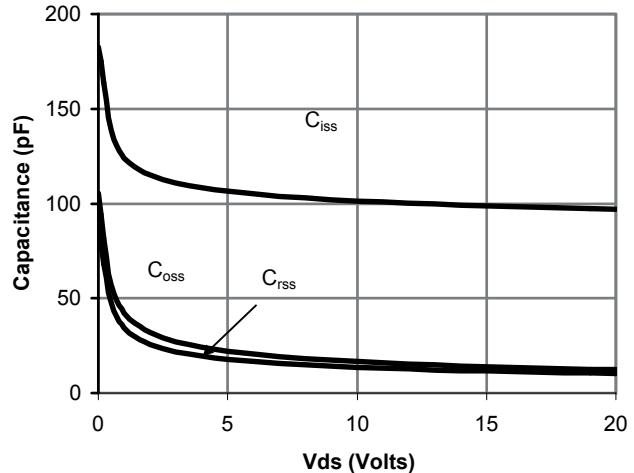
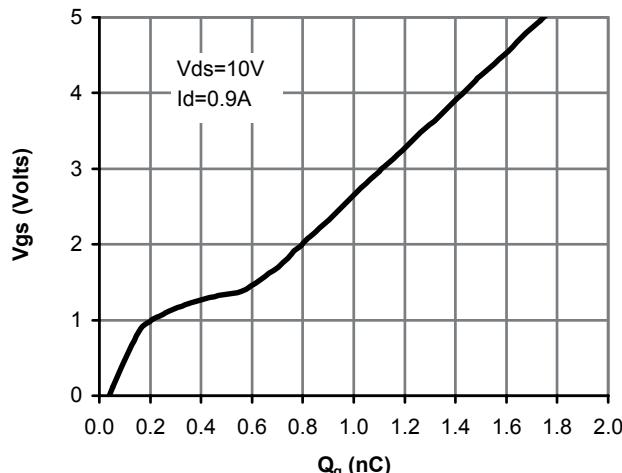


Figure 6: Body-Diode Characteristics

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■Electrical Characteristics (P-ch)

T_a=25°C

Parameter	Symbol	Conditions		Min.	Typ.	Max.	Unit	
STATIC PARAMETERS								
Drain-source breakdown voltage	BV _{dss}	Id=-250μA, V _{gs} =0V		-20			V	
Zero gate voltage drain current	Id _{ss}	V _{ds} =-16V, V _{gs} =0V	T _j =55°C			-1	μA	
						-5	μA	
Gate-body leakage current	I _{gss}	V _{ds} =0V, V _{gs} =±8V				±10	μA	
Gate threshold voltage	V _{gs(th)}	V _{ds} =V _{gs} , Id=-250μA		-0.5	-0.6	-0.9	V	
On state drain current	I _{d(on)}	V _{gs} =-4.5V, V _{ds} =-5V		-3			A	
Static drain-source on-resistance	R _{ds(on)}	V _{gs} =-4.5V Id=-0.6A	T _j =125°C		415	550	mΩ	
					542	700		
		V _{gs} =-2.5V, Id=-0.5A			590	700		
		V _{gs} =-1.8V, Id=-0.4A			700	950		
Forward transconductance	G _{fs}	V _{ds} =-5V, Id=-0.6A			1.7		S	
Diode forward voltage	V _{sd}	Is=-0.5A, V _{gs} =0V			-0.86	-1.00	V	
Max. body-diode continuous current	I _s					-0.4	A	
DYNAMIC PARAMETERS								
Input capacitance	C _{iss}	V _{gs} =0V, V _{ds} =-10V, f=1MHz			114	140	pF	
Output capacitance	C _{oss}				17		pF	
Reverse transfer capacitance	C _{rss}				14		pF	
Gate resistance	R _g	V _{gs} =0V, V _{ds} =0V, f=1MHz			12	17	Ω	
SWITCHING PARAMETERS								
Total gate charge	Q _g	V _{gs} =-4.5V, V _{ds} =-10V Id=-0.6A			1.44	1.80	nC	
Gate-source charge	Q _{gs}				0.14		nC	
Gate-drain charge	Q _{gd}				0.35		nC	
Turn-on delay time	t _{d(on)}	V _{gs} =-4.5V, V _{ds} =-10V R _l =16.7Ω, R _{gen} =3Ω			6.5		ns	
Turn-on rise time	t _r				6.5		ns	
Turn-off delay time	t _{d(off)}				18.2		ns	
Turn-off fall time	t _f				5.5		ns	
Body diode reverse recovery time	t _{rr}	I _f =-0.6A, dI/dt=100A/μs			10	13	ns	
Body diode reverse recovery charge	Q _{rr}	I _f =-0.6A, dI/dt=100A/μs			3		nC	

NOTE :

1. The value of R_{θja} is measured with the device mounted on 1in² FR-4 board of 2oz. Copper, in still air environment with T_a=25°C. The value in any given applications depends on the user's specific board design, The current rating is based on the t ≤ 10s thermal resistance rating.
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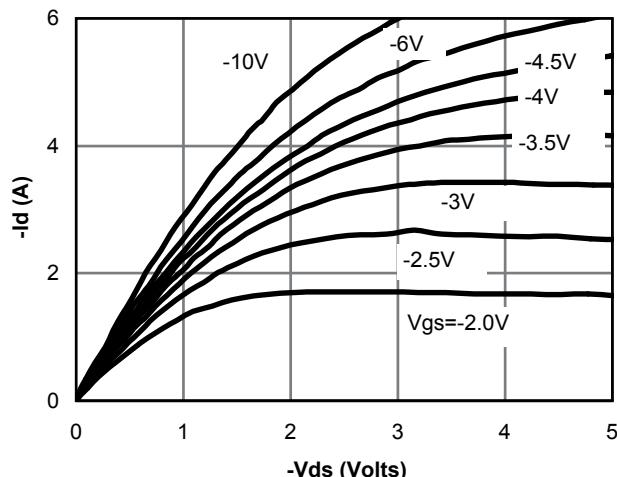


Fig 1: On-Region Characteristics

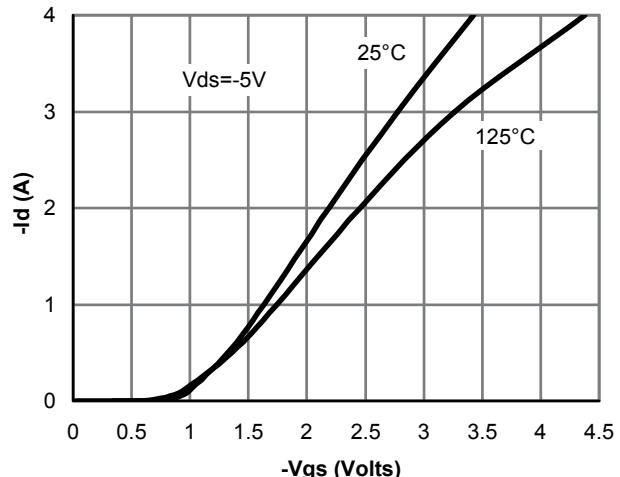


Figure 2: Transfer Characteristics

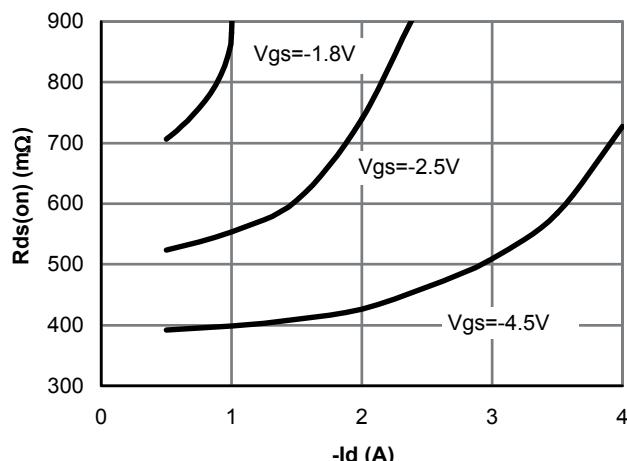


Figure 3: On-Resistance vs. Drain Current and Gate Voltage

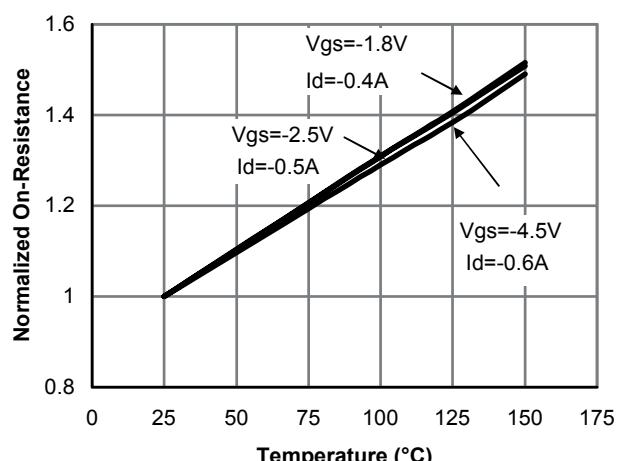


Figure 4: On-Resistance vs. Junction Temperature

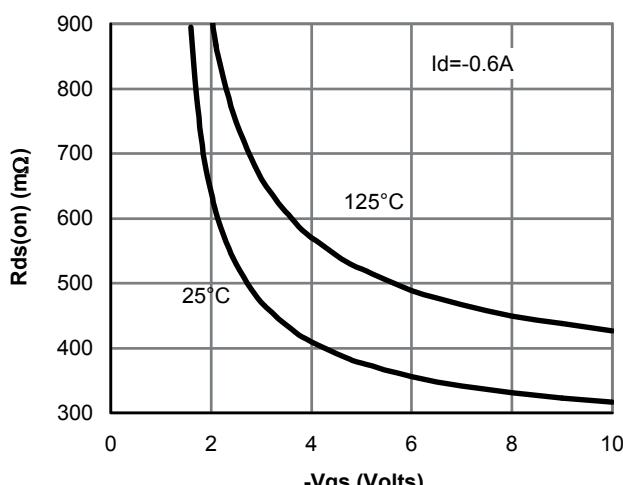


Figure 5: On-Resistance vs. Gate-Source Voltage

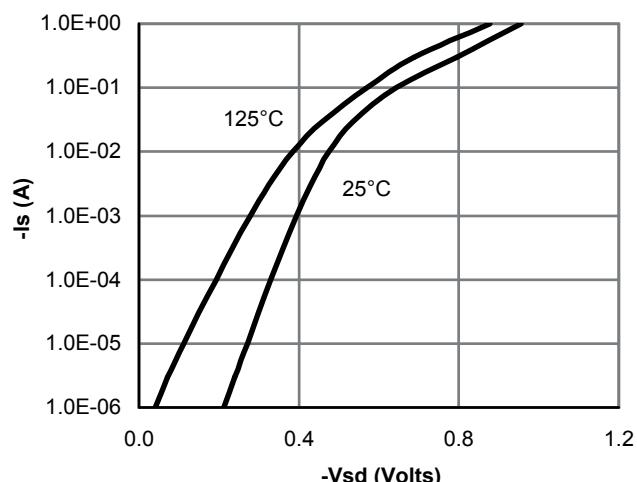


Figure 6: Body-Diode Characteristics

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